MILITARY SPECIFICATION
SEMICONDUCTOR DEVICE, DIODE, SILICON
TYPE 1N31

This amendment forms a part of Military Specification MIL-S-19500/236A
dated 20 October 1970, and is approved for use by all Departments and
Agoencies of the Department of Defense.

PAGE 3

3.4, second line: Delete "and II".
4.3: Delete and substitute:
   "4.3 Qualification inspection. Qualification inspection is not required".
4.4: Delete and substitute:
   "4.4 Quality conformance inspection. Quality conformance inspection shall
   consist of 100 percent Group A inspection".
4.4.1 and 4.4.2: Delete in their entirety.
4.5, second line: Delete "and II".

PAGES 4 AND 5

TABLE I: Delete LTPD column.
TABLE II: Delete in its entirety.

Custodians:
   Air Force - 17
   Army - ER
   Navy - EC

Review activities:
   Air Force - 11, 80
   Army - ER
   DLA - ES

User activities:
   Air Force - 13, 15, 19
   Army - SM
   Navy - AS, CG, MC, OS, SH

Preparing activity:
   Navy - EC

Agent:
   DLA - ES

(Project 5961-0788-3)

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